



DRAFT

Functional Specification

MEASUREMENT OF THE BEAM CURRENT IN THE LHC RINGS

Abstract

This document presents an analysis of the expected use of the beam current knowledge for machine operation and studies. The beam parameters to be derived from the beam current measurement are identified and their required accuracy estimated. These requirements are converted into functional specifications for the beam diagnostics instruments. The whole spectrum of possible beams is considered as well as design constraints.

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Approval group members:

Current Monitoring in LHC

2 types of current monitors

- **FBCT: to monitor the current of individual bunches**

1 at the end of each TI2 and TI8 transfer line, before the TED (2)

2/ring on each side of IP4 in the drift between Q7 and Q6 (4)

2 / at the beginning of each dump line (4)

(2 others presently discussed for injection kicker timing)

- **DCCT: to integrate the circulating current**

2/ring on each side of IP4, in the middle of the dogleg D3-D4 (4)

DCCT(1)

- **Basic parameters :** sampling frequency $n \times 50 \text{ Hz}$
sampling time $\leq 10 \text{ s}$

3 ranges proposed: $4 \mu\text{A} \rightarrow 1 \text{ mA}$ (250)
 $1 \text{ mA} \rightarrow 100 \text{ mA}$ (100)
 $100 \text{ mA} \rightarrow 1000 \text{ mA}$ (10)
- **Accuracy:** $\pm 1\text{‰}$ of full scale on range 1 = $\pm 1 \mu\text{A}$
 $\pm 1\text{‰}$ of readings on ranges 2 and 3
- **Resolution (noise):** $1 \mu\text{A/ s} \rightarrow 0.3 \mu\text{A/ 10 s}$ by sampling
 $\pm 2\mu\text{A/ s} \rightarrow \pm 0.6 \mu\text{A/ 10 s}$
- **Global accuracy:**

Range 1 ($4 \mu\text{A} \rightarrow 1 \text{ mA}$): $\pm (1^2 + 0.6^2)^{1/2} = \pm 1.2 \mu\text{A}$
Range 2 ($1 \text{ mA} \rightarrow 100 \text{ mA}$): $\pm 1.2 \mu\text{A} \rightarrow 100 \mu\text{A}$ ($\pm 1\text{‰}$)
Range 3 ($100 \text{ mA} \rightarrow 1000 \text{ mA}$): $\pm 100 \mu\text{A} \rightarrow 1 \text{ mA}$ ($\pm 1\text{‰}$)

DCCT(2)

	Pilot & low ions (9 μA)	Nominal ions (0.6 mA)	Ions (6mA)	Intermed. (55 mA)	Intermed. (200 mA)	Nominal (550 mA)
	r1	r1	r2	r2	r3	r3
Resolution	$\pm 0.6 \mu\text{A} / 10\text{s}$ $\pm 7 \%$	$\pm 0.6 \mu\text{A} / 10\text{s}$ $\pm 10^{-3}$	$\pm 0.6 \mu\text{A} / 10\text{s}$ $\pm 10^{-4}$	$\pm 0.6 \mu\text{A} / 10\text{s}$ $\pm 10^{-5}$	$\pm 0.6 \mu\text{A} / 10\text{s}$ $\pm 3.10^{-6}$	$\pm 0.6 \mu\text{A} / 10\text{s}$ $\pm 10^{-6}$
Requested						
circulating	$\pm 10 \%$ & $\pm 10 \%$	$\pm 1 \%$	$\pm 1 \%$	$\pm 1 \%$	$\pm 1 \%$	$\pm 1 \%$
lifetime	$\leq 10 \%$	$\leq 10 \%$	$\leq 10 \%$	$\leq 10 \%$	$\leq 10 \%$	$\leq 10 \%$
dI/dt						
interlocks most demanding	?	?	?	?	?	?
Accuracy	$\pm 1.2 \mu\text{A}$ $\pm 13 \%$	$\pm 1.2 \mu\text{A}$ $\pm 0.2 \%$	$\pm 6 \mu\text{A}$ $\pm 0.1 \%$	$\pm 55 \mu\text{A}$ $\pm 0.1 \%$	$\pm 200 \mu\text{A}$ $\pm 0.1 \%$	$550 \mu\text{A}$ $\pm 0.1 \%$
Requested						
circulating	$\pm 10 \%$ & $\pm 10 \%$	$\pm 1 \%$	$\pm 1 \%$	$\pm 1 \%$	$\pm 1 \%$	$\pm 1 \%$
absolute calibration FBCT	$\pm 5 \%$					$\pm 1 \%$

DCCT(3)

Lifetime processing with a resolution of $\pm 0.6 \mu\text{A}$:
Pessimistic as without processing

Ion beam of $10 \mu\text{A}$ - with $\tau = 10\text{h}$ - $\Delta\tau/\tau \leq \pm 100\%$ /30 mn

Nominal ion beam of 0.6 mA - with $\tau = 10\text{h}$ - $\Delta\tau/\tau \leq \pm 10\%$ /5 mn

Ion beam of 6 mA - with $\tau = 10\text{h}$ - $\Delta\tau/\tau \leq \pm 10\%$ /30 s

intermediate beam of 55 mA - with $\tau = 10\text{h}$ - $\Delta\tau/\tau \leq \pm 4\%$ /10 s
(1/10 of nominal)

with $\tau = 100\text{h}$ - $\Delta\tau/\tau \leq \pm 40\%$ /10 s
 $\pm 10\%$ /40 s

FBCT (1)

Basic parameters : integrator rms noise : 800 μV on 1 V (1/ 1250)

global noise level : * 5 ?? / 5 **sampling**

calibration : 1 ‰

2 ranges proposed : 0 \rightarrow 10^{10} p (16 μA)

0 \rightarrow $1.7 \cdot 10^{11}$ p (272 μA)

($1.15 \cdot 10^{11}$ p = 184 μA)

- **Accuracy:** $\pm 1\text{‰}$ of readings

- **Resolution (noise):** $\pm 2 \times (\text{F.S.} / 1250 \text{ (rms)}) * 5 / 5$
 - pilot: $\pm 8 \cdot 10^7$ $\pm 1.6 \cdot 10^7$
 - nominal: $\pm 1.4 \cdot 10^9$ $\pm 0.27 \cdot 10^9$

- **Global accuracy:**
-

Range 1 (0 \rightarrow 10^{10} p (16 μA)):

pilot:

$$1 \text{ passage: } \pm \left((5 \cdot 10^6)^2 + (2 \cdot 8 \cdot 10^6 * 5)^2 \right)^{1/2} = \pm 80 \cdot 10^6 = \pm 8 \cdot 10^7 \text{ p}$$

($\pm 2\%$)

$$\text{sampling: } \pm \left((5 \cdot 10^6)^2 + (2 \cdot 8 \cdot 10^6 * 5 / 5)^2 \right)^{1/2} = \pm 17 \cdot 10^6 = \pm 1.7 \cdot 10^7$$

($\pm 0.3\%$)

Range 2 (0 \rightarrow $1.7 \cdot 10^{11}$ p (272 μA)):

Nominal:

$$1 \text{ passage: } \pm \left((1.15 \cdot 10^8)^2 + (2 \cdot 1.4 \cdot 10^8 * 5)^2 \right)^{1/2} = \pm 14 \cdot 10^8 = \pm 1.4 \cdot 10^9 \text{ p}$$

($\pm 1.2\%$)

$$\text{sampling: } \pm \left((1.15 \cdot 10^8)^2 + (2 \cdot 1.4 \cdot 10^8 * 5 / 5)^2 \right)^{1/2} =$$

$\pm 3 \cdot 10^8 \text{ p}$

($\pm 0.3\%$)

FBCT (2)

	Pilot		Nominal	
	one passage	averaging	one passage	averaging
RESOLUTION	$\pm 8 \cdot 10^7$ p ± 1.6 %	$\pm 1.6 \cdot 10^7$ p ± 0.3 %	$\pm 1.4 \cdot 10^9$ p ± 1.2 %	$\pm 0.27 \cdot 10^9$ p ± 0.23 %
requested injection ϵ (relative)	± 20 %		± 1 %	
dump ϵ	± 5 %		± 1 %	
circulating cross-calibration		± 5 % ± 5 %		± 1 % ± 1 %
lifetime		≤ 10 %		≤ 10 %
ACCURACY	$\pm 8 \cdot 10^7$ p ± 1.6 %	$\pm 1.7 \cdot 10^7$ p ± 0.3 %	$\pm 1.4 \cdot 10^9$ p ± 1.2 %	$\pm 0.3 \cdot 10^9$ p ± 0.3 %
requested injection ϵ (absolute)			± 3 %	
dump ϵ			± 2 %	
circulating absolute calibration		± 5 % (17% for 10^8 c) ± 5 %		± 1 % ± 1 %

FBCT (3)

Lifetime processing: same for pilot and nominal (same resolution)

Case of nominal: $N=1.15 \cdot 10^{11}$ p

τ	1 h	10 h	100 h
dN/dt	$3.2 \cdot 10^7$ p/s $= 1.9 \cdot 10^9$ p/mn	$3.2 \cdot 10^6$ p/s	$3.2 \cdot 10^5$ p/s
$d\tau/\tau$	$\leq \pm 10\%$ /mn	$\leq \pm 10\%$ /10 mn ?	$\leq \pm 100\%$ /10mn ?

Usage	Threshold	Accuracy
Beam presence flag	$I_{\text{tot}} > n \times 10^9$ n=2-4	$(0.5-1) \times 10^9$ p
Safe beam flag	$I_{\text{tot}} < n \times 10^{11}$ n=2-10	10%
Beam intensity limit	Any value $> n \times 10^9$ n=5	5% at high I ($> 10^{12}$) 10% at lower I
Loss rate – slow	$dI/dt > 10^{11}$ p/s	5-10%
Loss rate – fast Turn by turn	$dI/dt > n \times 10^{11}$ p/turn n=3-6 $3 \cdot 10^{11} = 540 \mu\text{A}$	20% = 100 μA

measured in the lab. 1 mA rms (± 3 mA pktpk)

Table 5: Thresholds values for beam intensity related interlocks and flags.

Monitor type/mode		Beam scenario	Current range	Observation mode = sampling frequency	Observation range (gating)	Integration time per acquisition	Pilot accuracy resolution		Nominal bunch accuracy resolution	
Single-pass to few (100) pass	Bunch charge, injection efficiency, extraction efficiency	pilot bunch to ultimate SPS batch	2.10 ⁹ p/bunch to 1.7 10 ¹¹ p/bunch	Turn-by-turn	Bunch by bunch	1 turn	±20% = ±10 ⁹ p ±10% = ±0.5 10 ⁹ p	±20% = ±10 ⁹ p ±10% = ±0.5 10 ⁹ p	± 3% = ± 3.10 ⁹ p ± 2% = ± 2. 10 ⁹ p	± 1% = ± 10 ⁹ p ± 1% = ± 10 ⁹ p
Circulating bunch monitor	Extraction efficiency	pilot bunch & ion bunches to ultimate beam	2.10 ⁹ p/bunch to 1.7 10 ¹¹ p/bunch	Turn-by-turn	Bunch by bunch	2.10 ² turns	±10% = ±0.5 10 ⁹ p	±10% = ±0.5 10 ⁹ p	± 2% = ± 2. 10 ⁹ p	± 1% = ± 10 ⁹ p
	Normal mode					2.10 ² to 10 ⁴ turns	±10% = ±0.5 10 ⁹ p	±10% = ±0.5 10 ⁹ p	± 1% = ± 10 ⁹ p	± 1% = ± 10 ⁹ p
	Bunch lifetime (1mn to 20 hours)					10 ⁴ turns to 10 ⁵ turns	Pilot lifetime of 10h within 10s with 10% accuracy ↔ resolution 1.5 10 ⁵ p/10s		Nominal bunch lifetime of 10h within 10s with 10% accuracy ↔ resolution 3.2 10 ⁶ p/10s	
	Absolute calibration						±5% of pilot = ±0.5 μA		±1% of nominal bunch = ±2 μA	
	Cross calibrating – tr. lines						±10%		±2%	
Circulating beam monitor	Normal mode	4 μA to 860 mA	N turns	Whole beam	2.10 ² to 10 ⁴ turns	I ≈ 10 μA: accuracy: ± 10% resolution: ± 10%	I ≥ 500 μA: accuracy: ± 1% resolution: ± 1%			
	Cross-calib DCCT-FCT				10 ⁴ turns	±10% at pilot current		±1% at nominal bunch current		
	Beam lifetime (1mn to 100 hours)				10 ⁴ turns to 10 ⁵ turns	Beam lifetime of 100h within 10s with 10% accuracy ↔ resolution 1.8 μA				
	Machine interlocks : I					±10% accuracy at pilot current ±5% accuracy for N > 10 ¹² protons				
	Machine interlocks:dI/dt					?				

Table 6: Acquisition parameters and necessary accuracy and resolution.

